



**\*EXAMINER:** Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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Sheet 1 of 1

FORM PTO 1449 (modified)  U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE			ATTY DOCKET NO. <b>03500.016616.1</b>	APPLICATION NO. <b>10/645,582</b> Divisional of Application No. <b>10/214,105</b>			
LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary)			APPLICANT <b>HIROKAZU KOMURO ET AL.</b>				
August 22, 2003			FILING DATE <b>August 22, 2003</b>	GROUP <b>2028 3729</b>			
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME		CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TN	5,478,606	12/1995	Ohkuma et al.				
	5,872,582	02/1999	Pan				
	5,943,074	08/1999	Kashino et al.				
	6,095,640	08/2000	Ishinaga et al.				
	6,164,763	12/2000	Sugama et al.				
	6,113,224	09/2000	Sugama et al.				
	6,180,018 B1	01/2001	Miyagawa et al.				
	6,196,667 B1	03/2001	Hiroki et al.				
TN	6,199,972 B1	03/2001	Ishinaga et al.				
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY		CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
TN	JP 54-51837	04/1979	Japan				Abstract
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	<i>Tom Wagner</i>		DATE CONSIDERED		<i>3/10/05</i>		

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August 22, 2003			FILING DATE <b>August 22, 2003</b>	GROUP <b>3729</b>		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<u>TN</u>	6,206,505 B1	03/2001	Yoshibira et al.			
	6,286,940 B1	09/2001	Sugiyama et al.			
	6,374,482 B1	04/2002	Mihara et al.			
	6,378,992 B2	04/2002	Kudo et al.			
	6,378,993 B1	04/2002	Ozaki et al.			
	6,386,686 B1	05/2002	Kubota et al.			
	6,386,832 B1	05/2002	Taneya et al.			
<u>TM</u>	6,390,604 B2	05/2002	Kashino et al.			
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	<u>Mr. Nagayoshi</u>		DATE CONSIDERED	<u>3/10/05</u>		

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FORM PTO 1449 (modified)

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PATENT AND TRADEMARK OFFICELIST OF REFERENCES CITED BY APPLICANT(S)  
(Use several sheets if necessary)

August 22, 2003

ATTY DOCKET NO.  
03500.016616.1APPLICATION NO. 10/645,582  
Divisional of  
Application No. 10/214,105APPLICANT  
HIROKAZU KOMURO ET AL.FILING DATE  
August 22, 2003GROUP  
~~2003~~

3729

## U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TN	6,402,302 B1	06/2002	Ozaki et al.			
	6,409,296 B1	06/2002	Misumi et al.			
	6,409,317 B1	06/2002	Shimazu et al.			
	6,435,661 B1	08/2002	Inoue et al.			08/31/00
	6,435,670 B1	08/2002	Inoue et al.			02/13/01
	6,439,700 B1	08/2002	Ishinaga et al.			07/24/00
	6,450,776 B1	09/2002	Taneya et al.			07/28/99
TN	6,455,112 B1	09/2002	Ohkuma et al.			05/15/00

## FOREIGN PATENT DOCUMENTS

	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT

## OTHER DOCUMENTS (Including Author, Date, Pertinent Pages, Etc.)


EXAMINER

*Zac Nguyen*

DATE CONSIDERED

3/10/05

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August 22, 2003			FILING DATE <b>August 22, 2003</b>	GROUP <b>3729</b>		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TN	6,457,816 B1	10/2002	Ishinaga et al.			07/09/97
	6,464,342 B1	10/2002	Kubota et al.			12/03/99
	6,464,345 B2	10/2002	Kubota et al.			02/08/01
	6,485,132 B1	11/2002	Hiroki et al.			12/07/98
	6,491,380 B2	12/2002	Taneya et al.			12/03/98
	6,491,382 B2	12/2002	Taneya et al.			07/27/01
	6,497,475 B1	12/2002	Kubota et al.			08/31/00
TN	6,513,914 B2	02/2003	Misumi et al.			07/30/01
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Permanent Page, etc.)						
EXAMINER	<i>Zac Taguevee</i>		DATE CONSIDERED	<i>3/10/05</i>		

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August 22, 2003			FILING DATE <b>August 22, 2003</b>	GROUP <del>2000</del> <b>3729</b>		
U.S. PATENT DOCUMENTS						
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
<u>TN</u>	<b>6,533,400 B1</b>	<b>03/2003</b>	<b>Kudo et al.</b>			<b>08/31/00</b>
	<b>6,540,336 B2</b>	<b>04/2003</b>	<b>Kubota et al.</b>			<b>12/04/98</b>
	<b>6,591,500 B1</b>	<b>07/2003</b>	<b>Suzuki et al.</b>			<b>06/02/00</b>
	<b>2002-0021337 A1</b>	<b>02/2002</b>	<b>Sugiyama et al.</b>			
	<b>2002-0030722 A1</b>	<b>03/2002</b>	<b>Ishinaga et al.</b>			
	<b>2002-0085048 A1</b>	<b>07/2002</b>	<b>Ishinaga et al.</b>			
	<b>2003-0011655 A1</b>	<b>01/2003</b>	<b>Miyagawa et al.</b>			<b>07/10/02</b>
	<b>2003-0030701 A1</b>	<b>02/2003</b>	<b>Sugiyama et al.</b>			<b>09/10/99</b>
<u>TN</u>	<b>2003-0038852 A1</b>	<b>02/2003</b>	<b>Kubota et al.</b>			<b>08/30/99</b>
FOREIGN PATENT DOCUMENTS						
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)						
EXAMINER	<u>Marie Nguyen</u>		DATE CONSIDERED	<u>3/10/05</u>		

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